Docket No.: 4698-039

#### IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of : ATTN: Certificate of Correction Branch

Inventors: Biing-Seng WU et al.

U.S. Patent Application No. 7,221,350 : Group Art Unit: 2673

: Allowed: November 16, 2006

Issue Date: May 22, 2007 : Examiner: NITIN PATEL

For: METHOD OF REDUCING FLICKERING AND INHOMOGENEOUS BRIGHTNESS IN LCD

### REQUEST FOR CERTIFICATE OF CORRECTION OF OFFICE MISTAKE UNDER 37 CFR 1.322

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

In reviewing the above-identified patent, errors on the part of the Patent and Trademark Office was discovered. Correction is required in order to conform with the Patent to the Official Record in the application.

The errors noted is set forth on one attached copy of form PTO-1050 Rev. 2-93 in the manner required by the Commissioner's Notice.

The change requested herein corrects an error of the Patent and Trademark Office and the Certificate should be issued without expense to the patentee under Rule 1.322 of the Rules of Practice. Accordingly, issuance of the Certificate of Correction is requested.

Please charge any shortage in fees due in connection with the filing of this paper to Deposit Account 07-1337 and please credit any excess fees to such deposit account.

Respectfully submitted

LOWE HAZETMAN HAM & BERNER, LLP

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Date: September 17, 2007

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(Also Form PTO-1050)

# UNITED STATES PATENT AND TRADEMARK OFFICE CERTIFICATE OF CORRECTION

	PATENT NO.	: 7,221,350	Page _ 1 _ of _ 1 _
	APPLICATION NO.:	09/826,096	
	ISSUE DATE :	: May 22, 2007	·
	INVENTOR(S) :	WU et al.	
	is nereby correct	d that an error appears or errors appear in the above-identified patent and t ted as shown below: m (73) Assignee:	hat said Letters Patent
	Please amend A	Assignee's name as follows from "Chi Mai Optoelectronics" toCHI MEI OF	PTOELECTRONICS
Column 6, Line 9 of Claim 6:			
Please amend the Line 9 as follows from: "gate voltage deformation means for, generating a" togate voltage deformation means for generating a			

MAILING ADDRESS OF SENDER (Please do not use customer number below):

LOWE HAUPTMAN HAM & BERNER LLP 1700 Diagonal Road, Suite 300 Alexandria, VA 22314

This collection of information is required by 37 CFR 1.322, 1.323, and 1.324. The information is required to obtain or retain a benefit by the public which is to file (and by the USPTO to process) an application. Confidentiality is governed by 35 U.S.C. 122 and 37 CFR 1.14. This collection is estimated to take 1.0 hour to complete, including gathering, preparing, and submitting the completed application form to the USPTO. Time will vary depending upon the individual case. Any comments on the amount of time you require to complete this form and/or suggestions for reducing this burden, should be sent to the Chief Information Officer, U.S. Patent and Trademark Office, U.S. Department of Commerce, P.O. Box 1450, Alexandria, VA 22313-1450. DO NOT SEND FEES OR COMPLETED FORMS TO THIS ADDRESS. SEND TO: Attention Certificate of Corrections Branch, Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450.

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- 9. A record from this system of records may be disclosed, as a routine use, to a Federal, State, or local law enforcement agency, if the USPTO becomes aware of a violation or potential violation of law or regulation.



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# (12) United States Patent Wu et al.

(10) Patent No.:

US 7,221,350 B2

(45) Date of Patent:

May 22, 2007

### (54) METHOD OF REDUCING FLICKERING AND INHOMOGENEOUS BRIGHTNESS IN LCD

(75) Inventors: **Biing-Seng Wu**, Hsin-Shih Village (TW); **Wen-Jyh Sah**, Hsin-Shih Village

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Village (TW)

(73) Assignee: Chi-Mai Optoelectronics Corp. (TW)

(\*) Notice: Subject to any disclaimer, the term of this patent is extended or adjusted under 35 U.S.C. 154(b) by 1074 days.

(21) Appl. No.: 09/826,096

(22) Filed: Apr. 5, 2001

(65) Prior Publication Data

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(30) Foreign Application Priority Data

Apr. 6, 2000 (TW) ...... 89106352 A

(51) Int. Cl. G09G 3/36 (2006.01)

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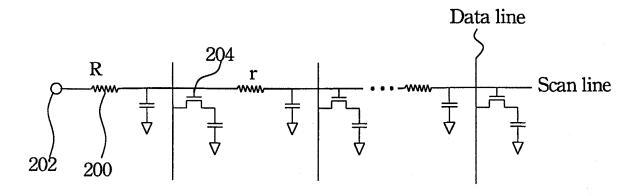
Primary Examiner-Nitin Patel

(57)

ABSTRACT

A method of reducing flickering and inhomogeneous brightness in an LCD. The method serially connects each scan line connecting a plurality of pixels in a row with a resistor to form a scan line circuit. The resistor is connected between the first pixel of the scan line and the voltage input terminal of the scan line, so that the gate voltage entering the TFT in the first pixel deforms. The voltage of the TFT decreases when it is turned off, minimizing screen flickering and inhomogeneous brightness due to the capacitor charge coupling effect between the first pixel and the last pixel on a scan line.

#### 10 Claims, 5 Drawing Sheets



What is claimed is:

1. A scan line circuit that solves screen flicker, imperfect exposure junctions and inhomogeneous brightness in a TFT-LCD, which includes a plurality of perpendicular scan lines and a plurality of horizontal data lines, each of the scan lines 5 connecting a plurality of pixel TFTs in a row and each of the data lines connecting a plurality of pixel TFTs in a column to form an array of the pixel TFTs, and a drain of the each pixel TFTs connecting a liquid crystal capacitor and a storage capacitor, wherein each of the scan line comprises: 10 gate voltage deformation means for deforming a gate

gate voltage deformation means for deforming a gate input voltage waveform input from an input terminal of the scan line, the gate voltage deformation means located only between the gate of the first pixel TFT in the row and the input terminal of the scan line.

- 2. The circuit of claim 1, wherein the gate voltage deformation means comprises a resistor.
- 3. The circuit of claim 2, wherein the resistance of the resistor is in the range between 10  $\Omega$ /sq and 100  $\Omega$ /sq.
- 4. The circuit of claim 1, wherein the gate voltage 20 deformation means comprises an ITO thin film.
- 5. The circuit of claim 1, wherein the gate voltage deformation means comprises a TFT that the TFT's gate connects the TFT's source directly.
- 6. A scan line circuit that solves screen flicker, imperfect 25 exposure junctions and inhomogeneous brightness in a TFT-

LCD, which includes a plurality of perpendicular scan lines and a plurality of horizontal data lines, each of the scan lines connecting a plurality of pixel TFTs in a row and each of the data lines connecting a plurality of pixel TFTs in a column to form an array of the pixel TFTs, and a drain of the each pixel TFTs connecting a liquid crystal capacitor and a storage capacitor, wherein each of the scan line comprises:

gate voltage deformation means for generating a deformed gate voltage waveform transmitted to the pixel TFTs connected to the same scan line, the gate voltage deformation means located between the gate of the first pixel TFT in the row and the input terminal of the scan line.

- 7. The circuit of claim 6, wherein the gate voltage deformation means comprises a resistor.
- 8. The circuit of claim 7, wherein the resistance of the resistor is in the range between 10  $\Omega$ /sq and 100  $\Omega$ /sq.
- 9. The circuit of claim 6, wherein the gate voltage deformation means comprises an ITO thin film.
- 10. The circuit of claim 6, wherein the gate voltage deformation means comprises a TFT that the TFT's gate connects the TFT's source directly.

\* \* \* \* \*